# APPROVAL SHEET

 Customer
 Name
 :

 Customer
 P/N
 :

 Frequency
 : 16.000000
 MHz

 Aker Approved P/N:
 CXA-016000-2D7D40

 Aker MPN
 : CXA-016000-2D7D40

 Rev.
 : 1

 ISSUE DATE
 : Mar.1.2018

APPROVED	CHECKED	PREPARED
Lei		Kiku
APPROVED BY CUS	STOMER	

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**RoHS** compliant



CUST. P/N :		
Aker Approved P/N:	CXA-01600	0-2D7D40
APPROVED :	Xtal	SHEET: 1 of 9
PREPARED :	Kiku	REV . : 1

	<u> </u>	1	
Rev.	Date	Reviser	Revise contents
1	2018/3/1	Kiku	Initial Released



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#### SMD CRYSTAL SPECIFICATION

#### 1. ELECTRICAL CHARACTERISTICS

■ Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement and tests are as follow:

Ambient temperature: 25±5 ℃

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature: 25±3°C

Relative humidity : 40%~70%

■ AKER Model: CXA-221

Oscillation Model : Fundamental

■ Cutting Model : AT CUT

■ Measurement Equipment : 350A(Measured FL)

■ Insulation Resistance : More than 500M ohms at DC 100V

		Electrical Spec				
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes
Nominal Frequency	FL	1	6.00000	0	MHz	
Frequency Tolerance			±20		ppm	at $25^{\circ}$ C $\pm 3^{\circ}$ C
Frequency Stability			±20		ppm	Operating Temp (Refer 25°C)
Load Capacitance	CL		12		pF	
Aging			±3		ppm	Year
Operating Temperature		-40	~	85	$^{\circ}\!\mathbb{C}$	
Storage Temperature Range		-55	~	125	$^{\circ}\!\mathbb{C}$	
Drive Level	DL			100	uW	
Effective Resistance Rr	Rr			100	Ω	
Shunt Capacitance	C0			3	pF	

<sup>\*</sup>Please kindly be noted that AKER DO NOT guarantee parts quality which involves human security application.\*

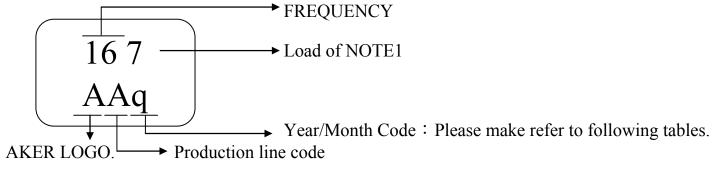


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#### 2. MARKING:



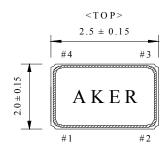
#### NOTE 1:

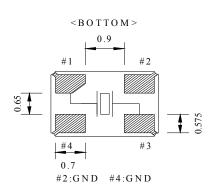
CODE	CL	CODE	CL	CODE	CL	CODE	CL
0	0pF	9	14pF	K	9.5pF	U	8.5pF
1	16pF	Α	32 pF	L	19.5pF	V	24pF
2	22pF	В	27pF	M	21.5pF	W	4pF
3	15pF	C	8pF	N	33pF	Х	39pF
4	20 pF	D	37pF	P	7pF	Y	26pF
5	30pF	E	25 pF	Q	15.5pF	Z	7.2pF
6	18pF	F	35pF	R	12.5pF	a	17pF
7	12pF	G	13pF	S	11pF	ъ	9.85pF
8	10 pF	Н	9pF	T	6pF	d	5pF

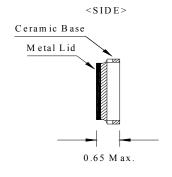
37	2007	2008	2009	2010
Year	2011	2012	2013	2014
	2015	2016	2017	2018
Month-	2019	2020	2021	2022
	2023	2024	2025	2026
JAN	Α	N	a	n
FEB	В	P	b	р
MAR	С	Q	С	q
APR	D	R	d	r
MAY	Е	S	е	S
JUN	F	Т	f	t
JUL	G	U	g	u
AUG	Н	V	h	ν
SEP	J	w	j	w
OCT	K	X	k	х
NOV	L	Y	1	у
DEC	M	Z	m	Z

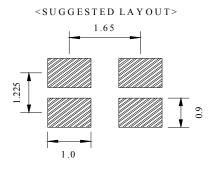
(Unit:mm)

#### 3. DIMENSION:











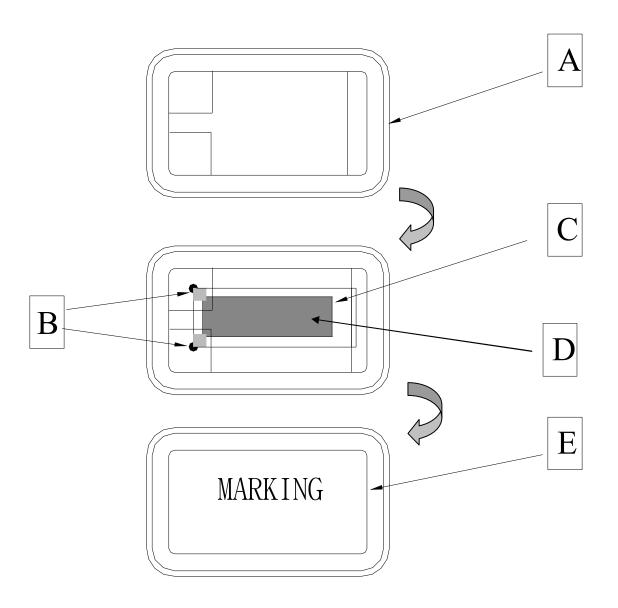
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### 4. STRUCTURE ILLUSTRATION



PREPARED

	COMPONENTS MATERIALS		CO	MPONENTS	MATERIALS
A	Base (Package)	Ceramic(Al2O3)+Kovar(Fe/Co/Ni)	D	Electrode	Cr / Ag
В	Conductive adhesive	Ag / Silicon resin	Е	Lid	Fe/Co/Ni
С	Crystal blank	SiO <sub>2</sub>			

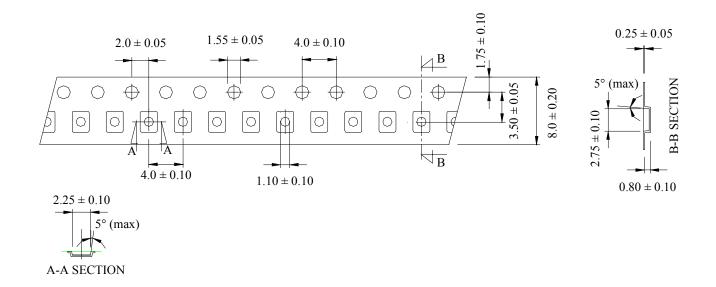


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#### 5. PACKING:

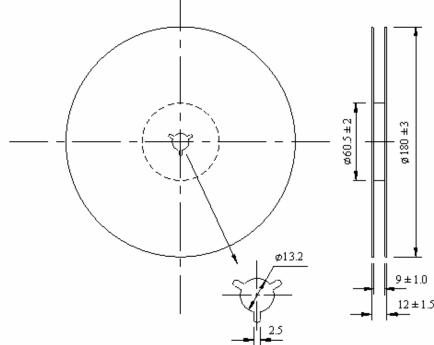
#### TAPE SPECIFICATION

(Unit:mm)



#### **OUTLINE DIMENSION**

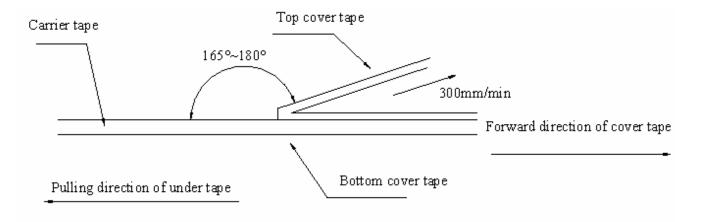
(Unit:mm)





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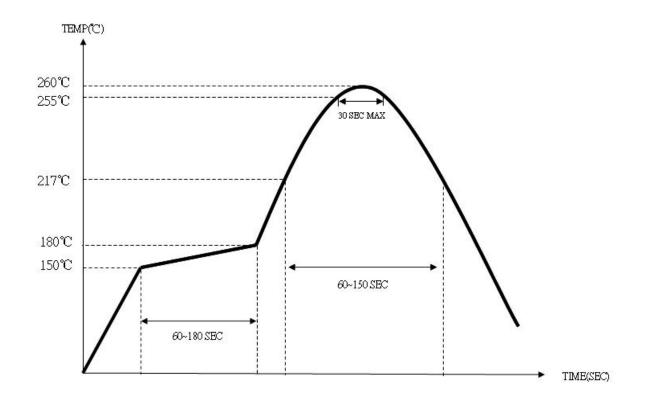
#### 6. COVER TAPE ADHESION STRENGTH:



\*\*\* In the case, the cover tape is pulled off under the above conditions, the cover tape adhesion strength should be 10.2g~71.4g Plastic tape:10.2g~71.4g

(Cover tape adhesion strength)

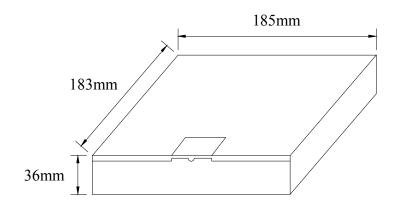
#### 7. SOLDERING REFLOW PROFILE





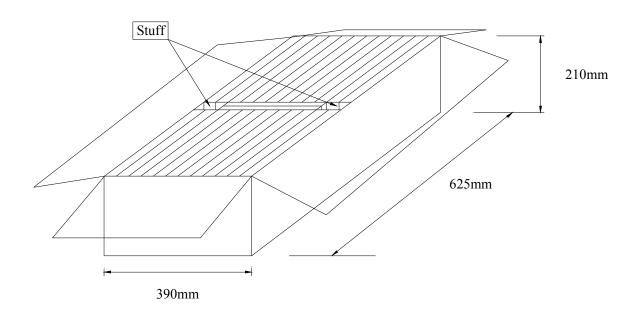
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## 8. PACKING:



BOX = 3000 PCS / REEL(MAX)





SMD product packs 32 BOX=The outside box packs (3000 PCS \*32 BOX = 96000 PCS)(MAX)



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#### MECHANICAI PERFORMANCE

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
9.1 Drop Test	The specimen is measured for its frequency and resistance before the test. It is then dropped from a hight of 100 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness.  ( in accordance with JIS-C0044 )	
0.2 Vibration Test	The specimen is measured for its frequency	
	and resistance before the test. Most them into	
	X,Y and Z axes, respectively, for the vibration test.	
	Vibration condition:	To satisfy the electrical
	Frequency range; 20~2000HZ	performance.
	Peak to peak amplitude: 1.52 mm	
	Peak acceleration: 20G	
	Sweep time: 20 minute / axis	
	Pendicular total test time: 4 hours	
)	( in accordance with MIL-STD-883F : 2007.3 )	_
2.3 Resistance to	The specimen is measured for its frequency and	
Soldering Test	resistance before the test. Place the specimen on	
	the belt of the converynace and let it pass through	
	the reflow with the presetted temperature condition.	
	After passing twice the reflow place, the specimen	
	under the referee condition for -~2 hours and then	
	measure its electrical performance.	
	Temperature Condition of IR Simulation:	
	The temperature range of the preheated section is setted at $150 \sim 180^{\circ}$ C for $60 \sim 120$ sec. For the next	
	section the temperature range is setted at 217~260 °C	
	for 45~90 sec. and within this time range the specimen	
	should be able to sustain at the peak temperature,	
	should be able to sustain at the peak temperature, $260+/-3^{\circ}$ °C, for 10 sec long.	
	( in accordance with JESD22-B106-B )	
9.4 Fine Leak	Place the specimen in a pressurized container and	+
Test	pressurize it with the detection gas ( mixed gas	Less than
1030	consisting of 95% or more helium) for at least 2 hours.	$1.0 * 10^{-8}$ atm .c.c. / sec,
	Complete the measurement of the concentration of	Helium
	helium within 30 min after taking it out from the	
	pressurized container.	
	( in accordance with MIL-STD-883F: 1014.11 )	
	The referee condition.	L
	Temperature $25 \pm 2$ °C	
	Humidity $44 \sim 55 \%$	
	Pressure $86 \sim 106 \text{ kPa}$	

( in accordance with MIL-STD-883E: 1014.9)



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## 10. CLIMATIC RESISTANCE

10. CLIMATIC RESISTANCE					
TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE			
10.1 Low Temp Exposure Test	The specimen is measured for its frequency and resistance before the test . Place the specimen in the chamber and kept it at the temperature of - $40 \pm 3^{\circ}$ C for $168 \pm 6$ hours . Take the specimen out of the chamber and measure itselectrical performance after leaving $1 \sim 2$ hours under the referee condition. ( in accordance with JIS-C0020 )				
10.2 Aging Test	The specimen is measured for its frequency and resistance before the test . Place the specimen in the testing chamber and keep it at the temperature of $+125 \pm 3^{\circ}$ C for $720 \pm 48$ hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for $1 \sim 2$ hours under the referee condition . ( in accordance with JIS-C0021 )	To satisfy the electrical performance.			
10.3 High Temperature & High Humidty	The specimen is measured for its frequency and resistance before the test. Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5$ °C and humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and then take the specimen out and measure its electrical performance after leaving for $1 \sim 2$ hours under the referee condition. ( in accordance with MIL-STD-883F: 1004.7 )				
10.4 Temperature Cycle Test	The specimen is measured for its frequency and resistance before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + $125 \pm 3$ °C ( $15\pm 3$ min).				

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